

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.	: 10/652,323)	I hereby certify that this paper and the
)	documents referred to therein are being
Applicants	: Elqaq et al.)	deposited with the United States Postal
Filed	: August 29, 2003)	Service with sufficient postage, as first
)	class mail, in an envelope addressed to:
Title: Method	d of Making an Optical)	Commissioner for Patents, P.O. Box 1450,
Device in Silicon)	Alexandria, VA 22313-1450
)	
Art Unit	: Not yet assigned)	Dated: November 25, 2003
Examiner	: Not yet assigned)	•
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Atty Docket	: 30320/15128)	M. N. I Milly adde
Customer No.	. : 04743)	Thing I have been
	<u>.</u>		Michael Muczyński

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

The publications listed on the enclosed Form PTO-1449 are submitted pursuant to 37 CFR §§ 1.56, 1.97, and 1.98. Copies of the publications are enclosed as necessary.

Respectfully submitted,

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PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Atty. Docket No. Serial No. 30320/15128 10/652,323
Applicant

INFORMATION DISCLOSURE STATEMENT

Elqaq et al.

Filing Date Group

August 29, 2003

U.S. PATENT DOCUMENTS						
*Examiner Initials	Document Number	Issue Date	Name	Class	Subclass	Filing Date if Appropriate

FOREIGN PATENT DOCUMENTS							
*Examiner Initials	Document Number	Publication Date	Country	Class	Subclass	Translatio	on
						Yes	No

	THER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) "Amorphous Silicon Waveguides and Light Modulators for Integrated Photonics
1	Realized by Low Temperature Plasma Enhanced Chemical Vapor Deposition," Opt.
	Lett. vol. 21, no. 24, p. 2002-2004 (1996).
	B. Jalali et al., "Advances in Silicon-on-Insulator Optoelectronics" IEEE J. Sel. Top.
	Quantum Elec., vol. 4, no. 6, p. 938-947 (Nov./Dec. 1998).

Examiner	Date Considered			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not				
in conformance and not considered. Include copy of this form with next communication to applicant.				